

40V, 160A N-CHANNEL POWER MOSFET

GENERAL DESCRIPTION

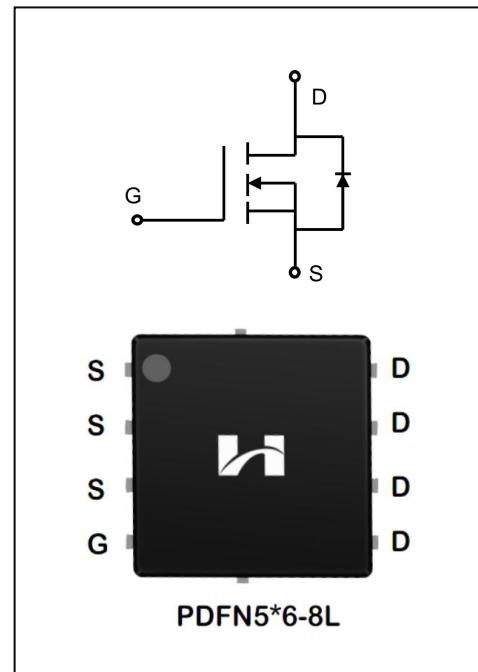
The SGM041R3T uses advanced SGT technology and design to provide excellent $R_{DS(on)}$ with low gate charge. It can be used in a wide variety applications.

Features

- ◆ $V_{DS}=40V$, $I_D=160A$
- ◆ $R_{DS(on)}$
TYP: $1.1m\Omega$ @ $V_{GS}=10V$
MAX: $1.3m\Omega$

Applications

- ◆ Power factor correction (PFC)
- ◆ Switched mode power supplies (SMPS)
- ◆ Uninterruptible power supply (UPS)
- ◆ LED lighting power



ORDERING INFORMATION

Part No.	Package	Marking	Material	Packing
SGM041R3T	PDFN5*6-8L	SGM041R3T	Pb Free	Reel

ABSOLUTE MAXIMUM RATINGS (T_J=25°C unless otherwise noted)

Characteristics	Symbol	Ratings	Unit
Drain-Source Voltage	V _{DS}	40	V
Gate-Source Voltage	V _{GS}	±20	V
Drain Current	I _D	160	A
T _C = 100°C	I _D	100	
Drain Current Pulsed(Note 1)	I _{DM}	420	A
Power Dissipation(T _C =25°C) -Derate above 25°C	P _D	92	W
Single Pulsed Avalanche Energy (Note 2)	E _{AS}	435	mJ
Operation Junction Temperature Range	T _J	-55~+150	°C
Storage Temperature Range	T _{stg}	-55~+150	°C
Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	TL	300	°C

THERMAL CHARACTERISTICS

Characteristics	Symbol	MAX	Unit
Thermal Resistance, Junction-to-Case	R _{θJC}	0.89	°C/W
Thermal Resistance, Junction-to-Ambient	R _{θJA}	50	°C/W

ELECTRICAL CHARACTERISTICS

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Off Characteristics						
Drain -Source Breakdown Voltage	B _{VDSS}	V _{GS} =0V, I _D =250μA	40	--	--	V
Drain-Source Leakage Current	I _{DSS}	V _{DS} =40V, V _{GS} =0V	--	--	1	uA
Gate-Source Leakage Current	I _{GSS}	V _{GS} =20V, V _{DS} =0V	--	--	100	nA
Gate-Source Leakage Current	I _{GSS}	V _{GS} =-20V, V _{DS} =0V	--	--	-100	
On Characteristics						
Gate Threshold Voltage	V _{GS(th)}	V _{GS} = V _{DS} , I _D =250μA	1.0	1.5	2.0	V
Static Drain- Source On State Resistance	R _{DS(on)}	V _{GS} =4.5V, I _D =20A	--	1.6	1.8	mΩ
		V _{GS} =10V, I _D =40A	--	1.1	1.3	
Dynamic Characteristics						
Gate Resistance	R _g	V _{GS} =0V; f=1.0MHZ	1	3.5	10	Ω
Input Capacitance	C _{iss}	V _{DS} =25V	--	3950	--	pF
Output Capacitance	C _{oss}		--	1140	--	
Reverse Transfer Capacitance	C _{rss}	f=1.0MHZ	--	85	--	
Switching Characteristics						
Turn-on Delay Time	t _{d(on)}	V _{DD} =20V, V _{DS} =10V R _G =3Ω; I _D =25A (Note 3.4)	--	13.5	--	ns
Turn-on Rise Time	t _r		--	32.6	--	
Turn-off Delay Time	t _{d(off)}		--	75.8	--	
Turn-off Fall Time	t _f		--	36.1	--	

Total Gate Charge	Q_g	$V_{DS}=24V, I_D=25A$ $V_{GS}=10V$ (Note 3.4)	--	42.2	--	nc
Gate-Source Charge	Q_{gs}		--	12.7	--	
Gate-Drain Charge	Q_{gd}		--	9.8	--	

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Continuous Source Current	I_s	Integral Reverse P-N Junction Diode in the MOSFET	--	--	160	A
Pulsed Source Current	I_{SM}		--	--	420	
Diode Forward Voltage	V_{SD}	$I_s=40A, V_{GS}=0V$	--	0.82	1.4	V
Reverse Recovery Time	T_{rr}	$I_F=40A, V_R=10V,$ $dI/dt=100A/\mu s$	--	85	--	ns
Reverse Recovery Charge	Q_{rr}		--	0.05	--	μC

1. Pulse width limited by maximum junction temperature

2. $L=0.5mH, V_{DD}=25V, V_G=10V, R_G=25\Omega$, starting $T_J=25^\circ C$ 3. Pulse Test: Pulse width $\leq 300\mu s$, Duty cycle $\leq 2\%$

4. Essentially independent of operating temperature

Typical Performance Characteristics

Figure 1.On-Region Characteristics

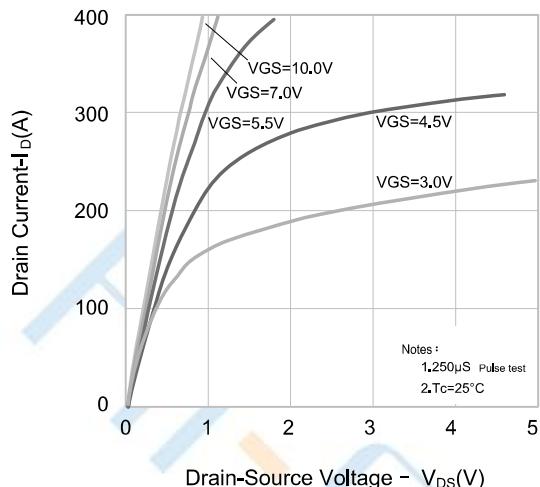


Figure 2.Transfer Characteristics

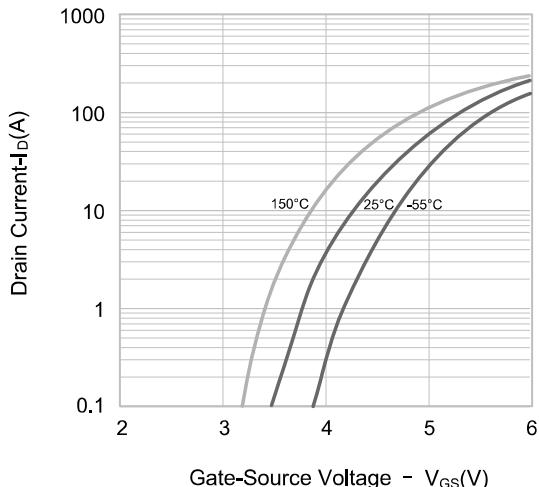


Figure 3.On-Resistance Variation vs. Drain-Current, Gate Voltage

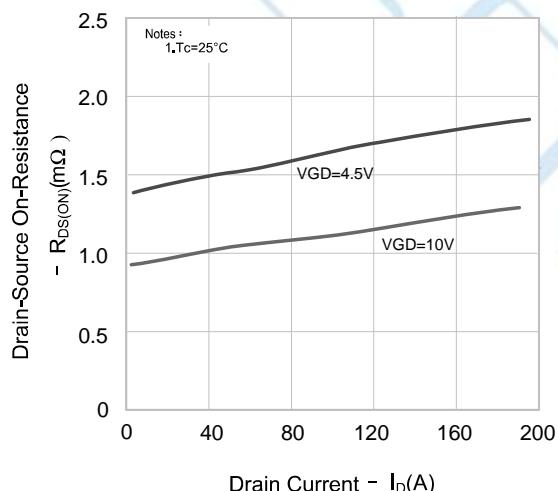


Figure 4.Body Diode Forward Voltage Variation vs. Source Current and Temperature

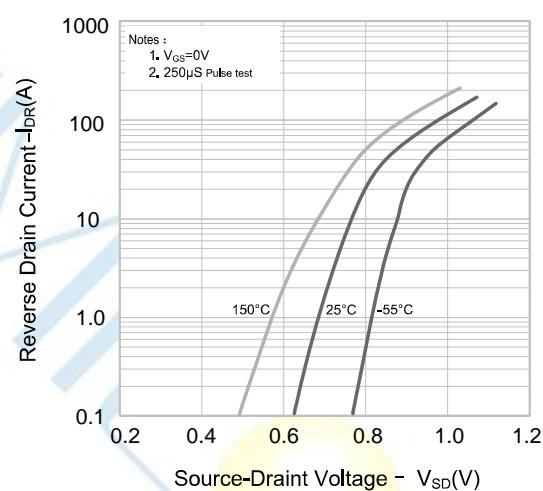


Figure 5.Capacitance Characteristics

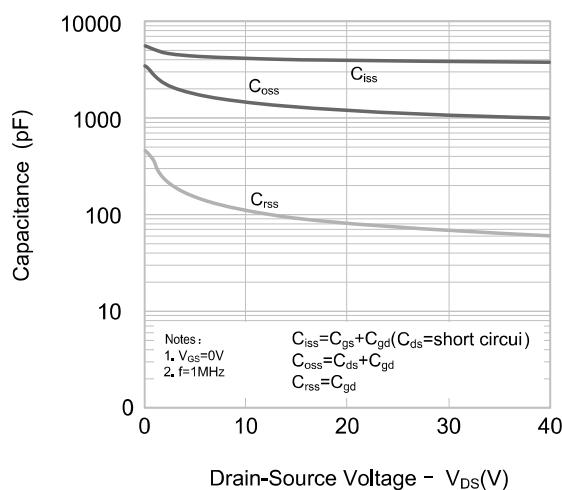
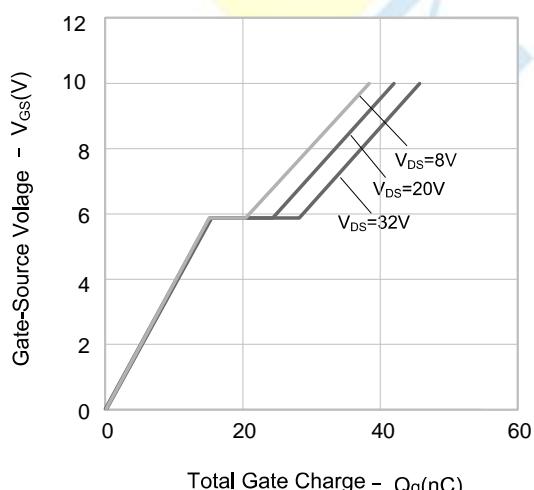


Figure 6.Gate Charge Characteristics



Typical Performance Characteristics

Figure 7.Breakdown Voltage Variation vs.Temperature

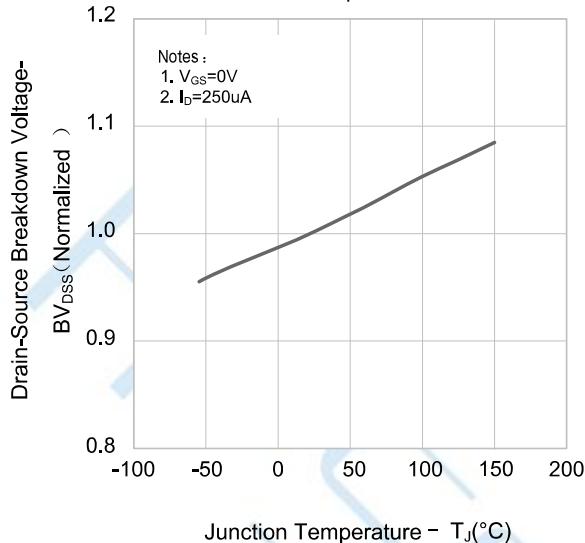


Figure 8.On-resistance Variation vs.Temperature

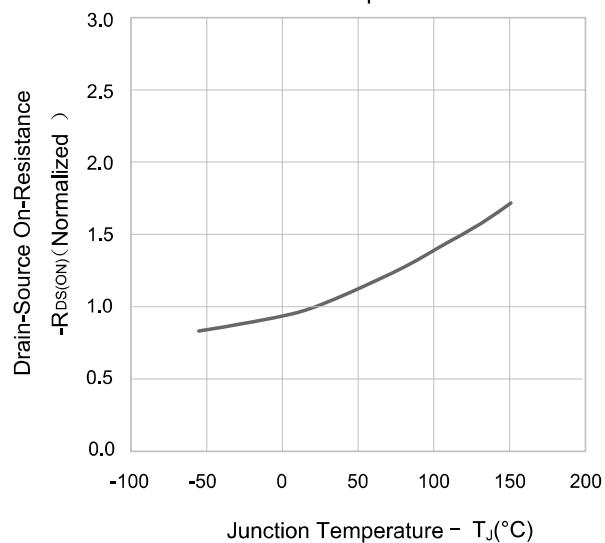
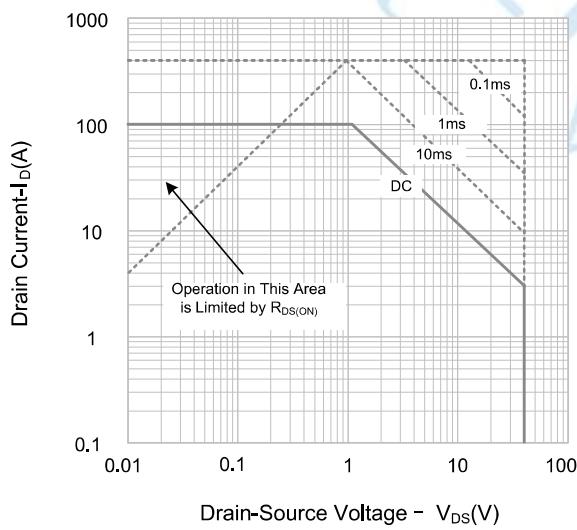
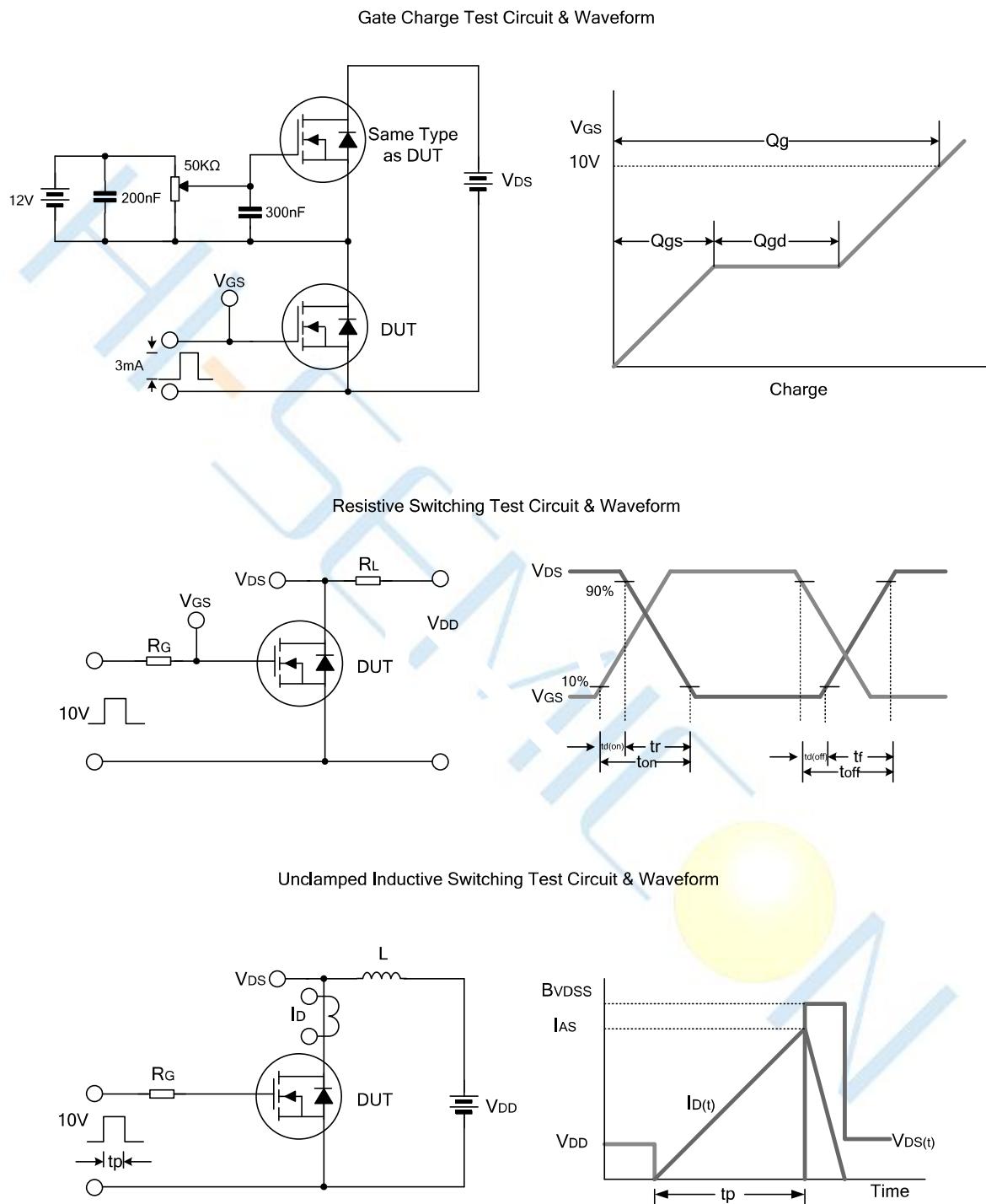


Figure 9.Max.Safe Operating Area

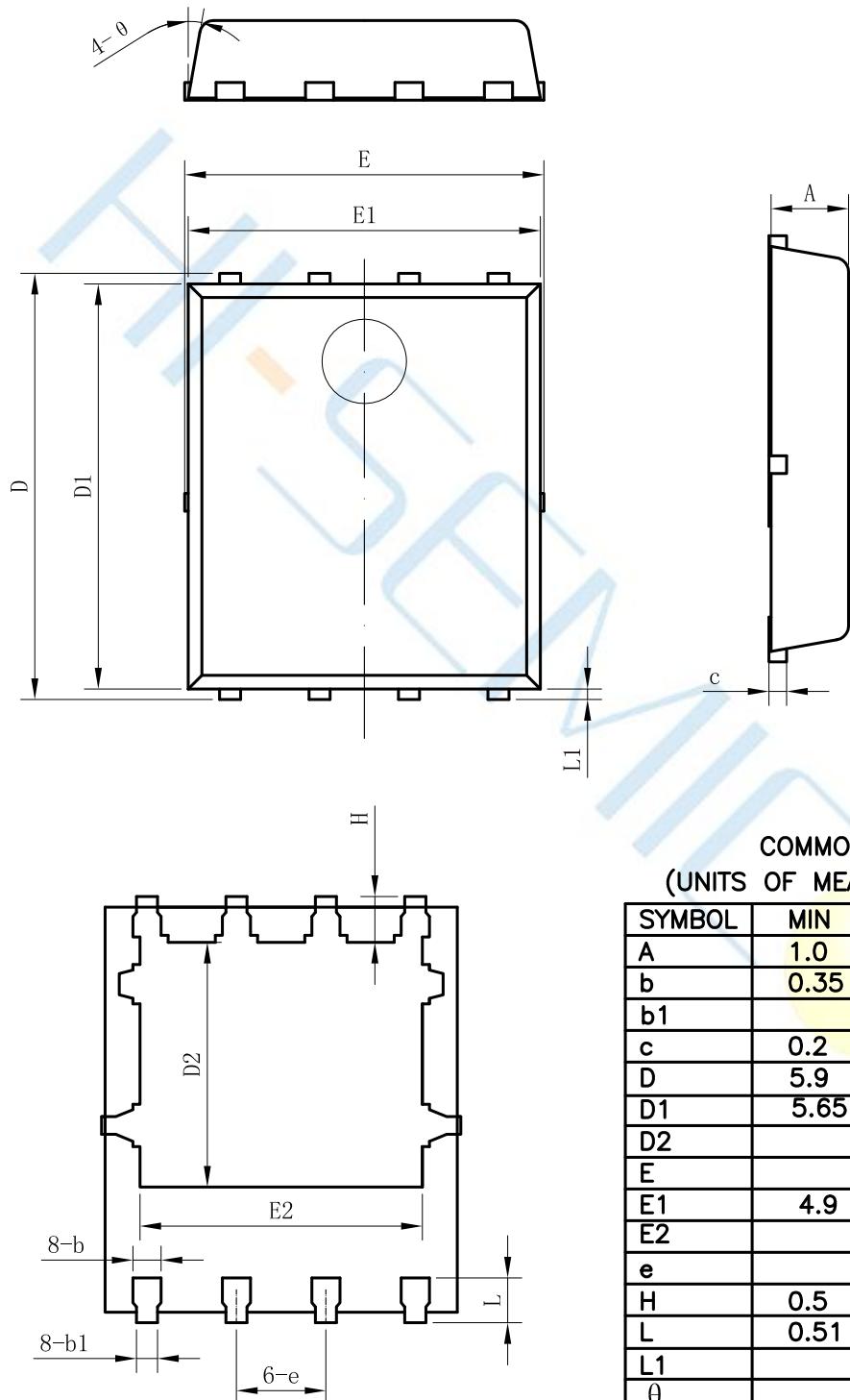


Test Circuit



Package Dimensions of PDFN5*6-8L

Unit:mm



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